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| <b>Search Notes</b><br> | <b>Application/Control No.</b><br>10633617 | <b>Applicant(s)/Patent Under Reexamination</b><br>SHIN ET AL. |
|  | <b>Examiner</b><br>Nhon T Diep             | <b>Art Unit</b><br>2621                                       |

| SEARCHED |               |           |          |
|----------|---------------|-----------|----------|
| Class    | Subclass      | Date      | Examiner |
| 375`     | 240.02-240.25 | 9/14/2009 | ND       |

| SEARCH NOTES                 |           |          |
|------------------------------|-----------|----------|
| Search Notes                 | Date      | Examiner |
| East search                  | 6/8/2008  | ND       |
| Consulted w/ 2621 during QAM | 2/12/2009 | ND       |
| East Search                  | 9/14/2009 | ND       |
| Cnsulted w/ Rao              | 9/11/2009 | ND       |

| INTERFERENCE SEARCH |          |           |          |
|---------------------|----------|-----------|----------|
| Class               | Subclass | Date      | Examiner |
| See attached        |          | 9/14/2009 | ND       |

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